

Today's outline - September 09, 2024



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- HW #2

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- APSU and other sources

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- APSU and other sources
- Detectors
 - Gas detectors
 - Scintillation counters
 - Solid state detectors
 - Area detectors

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Reading Assignment: Chapter 3.4

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Reading Assignment: Chapter 3.4

Homework Assignment #02:

Problems on Canvas

due Monday, September 16, 2024

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- APSU and other sources
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Reading Assignment: Chapter 3.4

Homework Assignment #02:
Problems on Canvas
due Monday, September 16, 2024

Homework Assignment #03:
Chapter 3: 1,3,4,6,8
due Monday, September 30, 2024



1. Knowing that the photoelectric absorption of an element scales as the inverse of the energy cubed, calculate:
 - (a) the absorption coefficient at 10keV for copper when the value at 5keV is 1698.3 cm^{-1} ;
 - (b) The actual absorption coefficient of copper at 10keV is 1942.1 cm^{-1} , why is this so different than your calculated value?
2. A 30 cm long, ionization chamber, filled with 80% helium and 20% nitrogen gases at 1 atmosphere, is being used to measure the photon rate (photons/sec) in a synchrotron beamline at 12 keV. If a current of 10 nA is measured, what is the photon flux entering the ionization chamber?
3. A 5 cm deep ionization chamber is used to measure the fluorescence from a sample containing arsenic (As). Using any noble gases or nitrogen, determine a gas fill (at 1 atmosphere) for this chamber which absorbs at least 60% of the incident photons. How does this change if you are measuring the fluorescence from ruthenium (Ru)?



4. Calculate the critical angle of reflection of 10 keV and 30 keV x-rays for:

- (a) A slab of glass (SiO_2);
- (b) A thick chromium mirror;
- (c) A thick platinum mirror.
- (d) If the incident x-ray beam is 2 mm high, what length of mirror is required to reflect the entire beam for each material?

5. Calculate the fraction of silver (Ag) fluorescence x-rays which are absorbed in a 1 mm thick silicon (Si) detector and the charge pulse expected for each absorbed photon. Repeat the calculation for a 1 mm thick germanium (Ge) detector.

APS upgrade



In 2023, the APS was shut down for a major rebuild with a totally new magnetic lattice.

APS upgrade

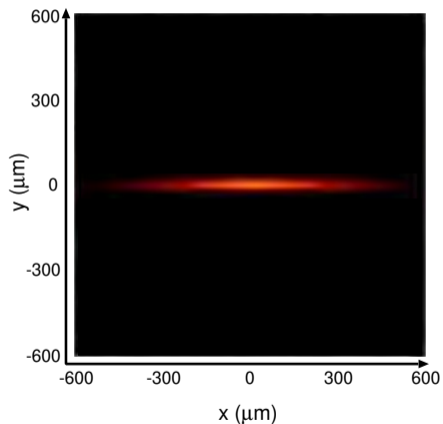


In 2023, the APS was shut down for a major rebuild with a totally new magnetic lattice. The biggest changes are the beam (source) size and emittance

APS upgrade



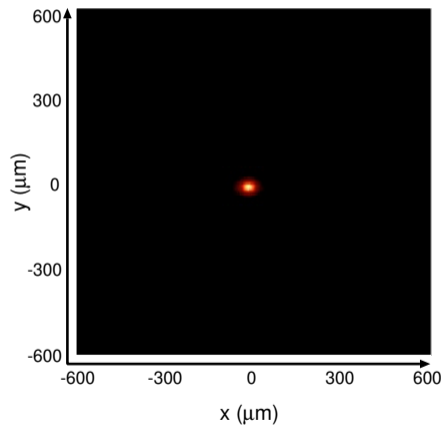
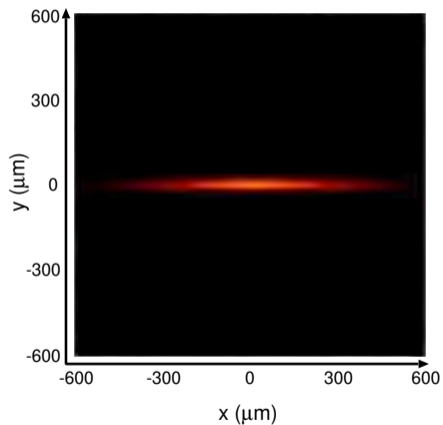
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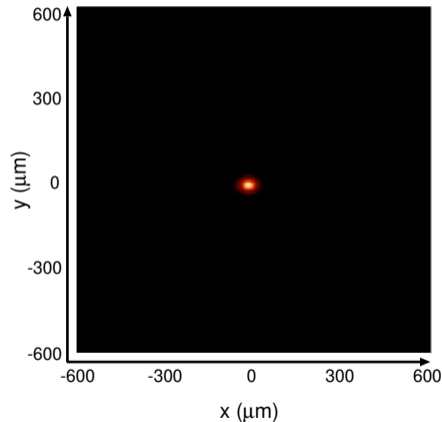
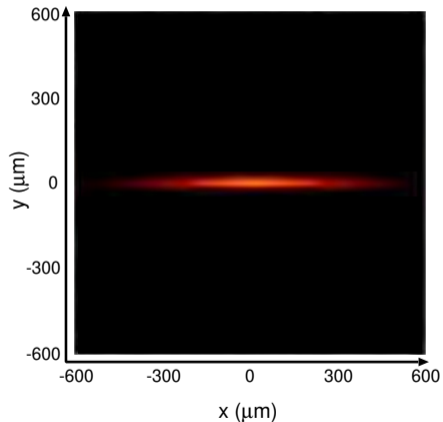
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APS upgrade



In 2023, the APS was shut down for a major rebuild with a totally new magnetic lattice. The biggest changes are the beam (source) size and emittance



The beam will be nearly square and there will be much more coherence from the undulators

APS-U magnet layout



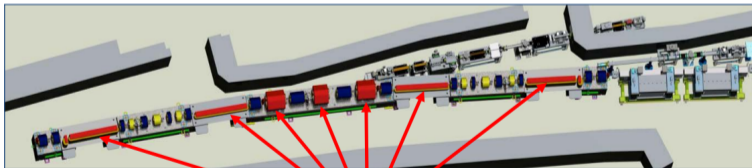
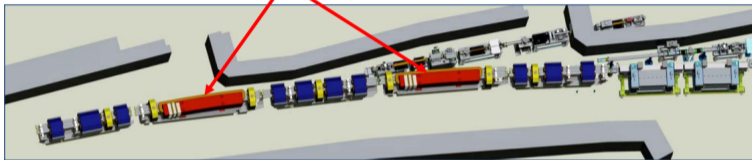
The APS upgrade will install a multi-bend achromat instead of the two bending magnets.

APS-U magnet layout



The APS upgrade will install a multi-bend achromat instead of the two bending magnets.

two dipole magnets – double-bend-achromat



Seven dipole magnets – multi-bend-achromat (MBA)

APS-U undulator performance



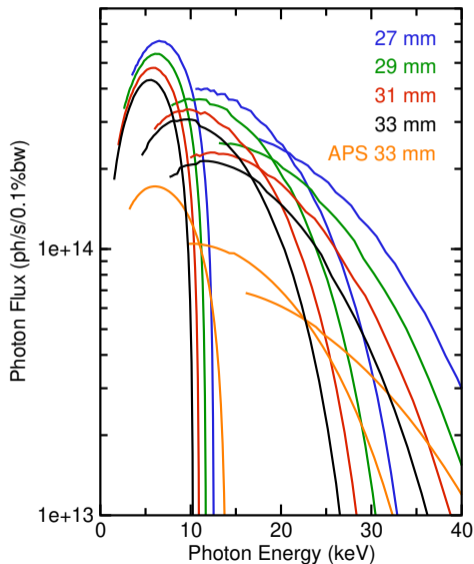
The multi-bend achromat will produce a diffraction-limited source with a lower energy (6.0 GeV) and doubled current (200 mA).

APS-U undulator performance



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Since MRCAT's science is primarily flux driven, the goal will be to replace the 2.4m undulator with one that outperforms the current 33mm period but with only modest increase in power.



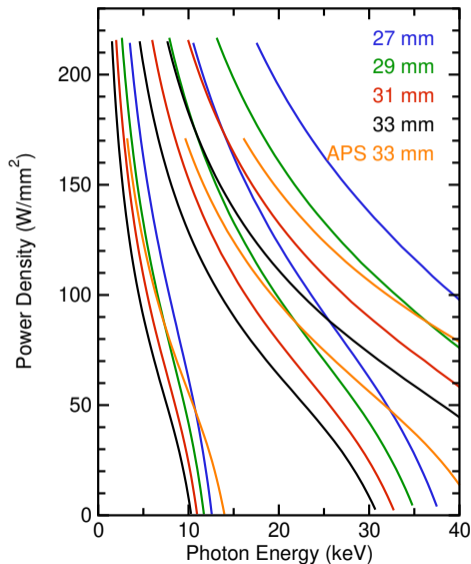
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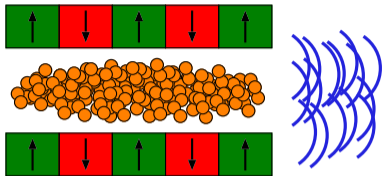
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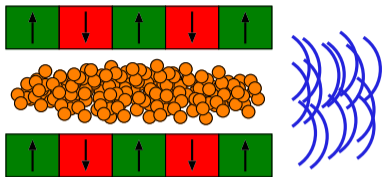
The APS-U is an example of a "4th" generation synchrotron source



Free electron laser

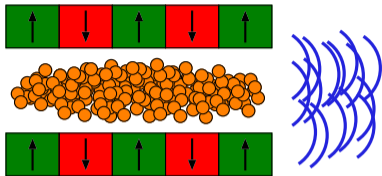


Free electron laser



Initial electron cloud, each electron emits coherently but independently

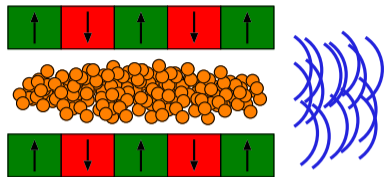
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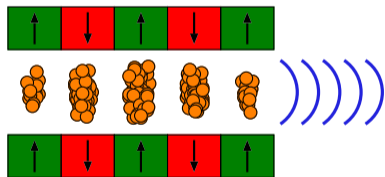
Over course of 100 m, electric field of photons, feeds back on the electron bunch

Free electron laser

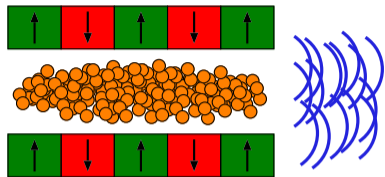


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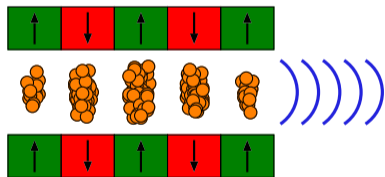


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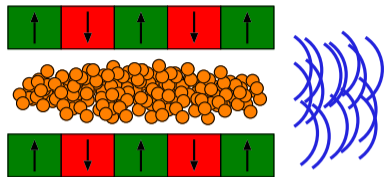
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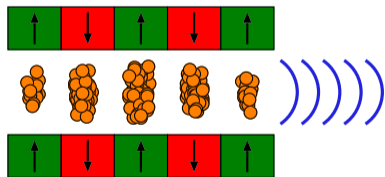
Microbunches form with period of FEL (and radiation in electron frame)

Free electron laser



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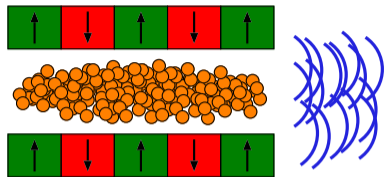
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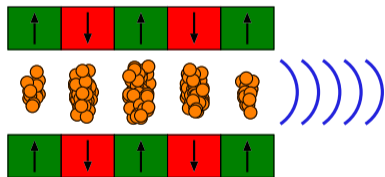
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Free electron laser



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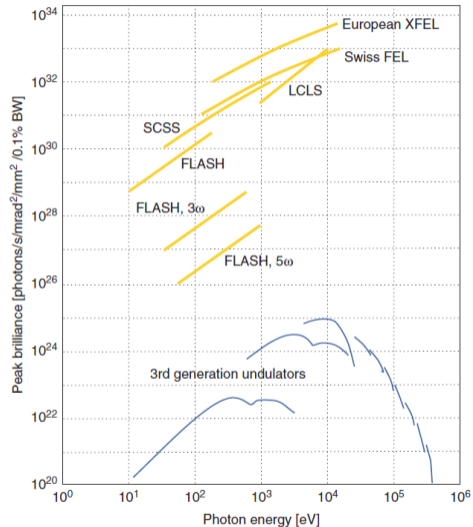
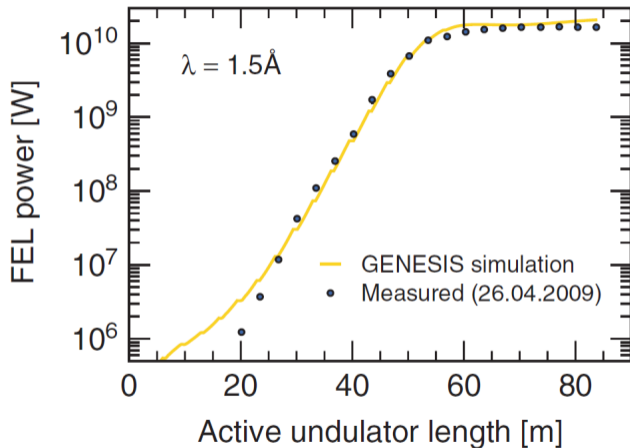


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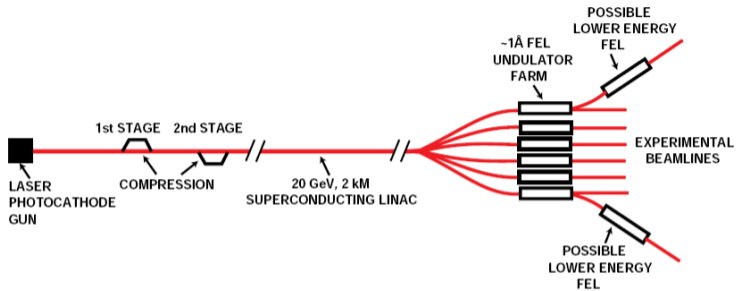
Each microbunch emits coherently with neighboring ones

Again, an alternative way to view this is that the pulse train from a 100m long undulator is long enough in time to produce a monochromatic and coherent frequency distribution when Fourier Transformed

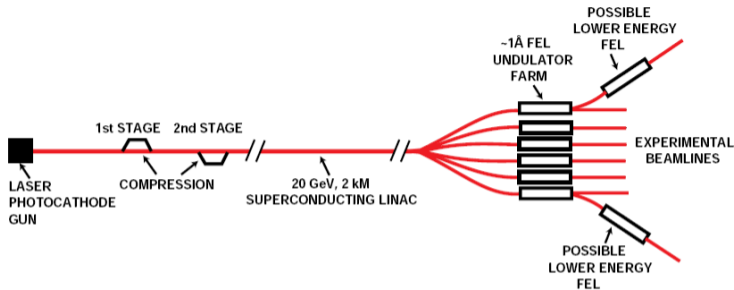
FEL performance



FEL layout

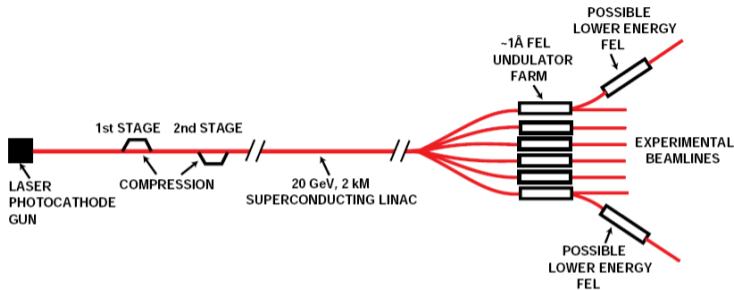


FEL layout



An FEL has a single accelerator whose electron beam is shunted sequentially through different undulators and end stations

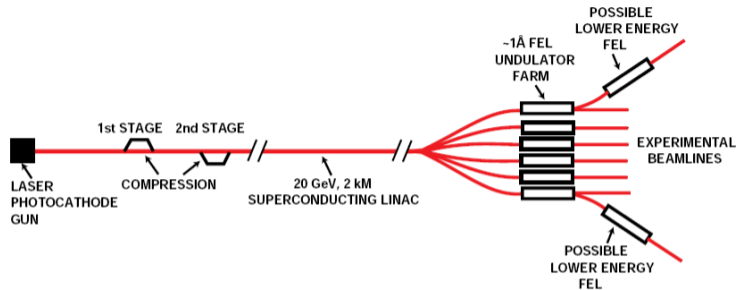
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The single pass of the electron beam permits a very low emittance to be achieved and thus higher coherence

FEL layout

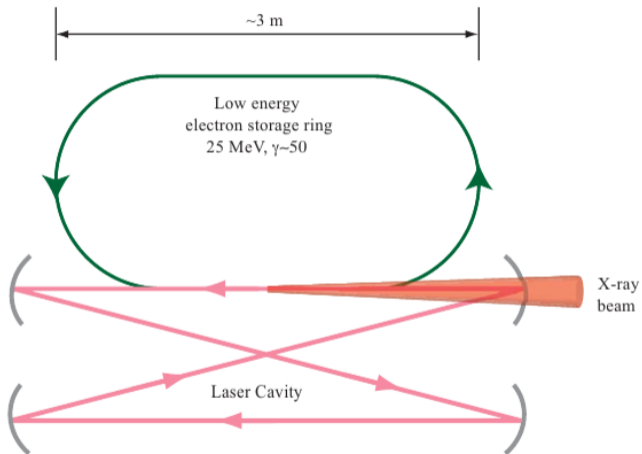


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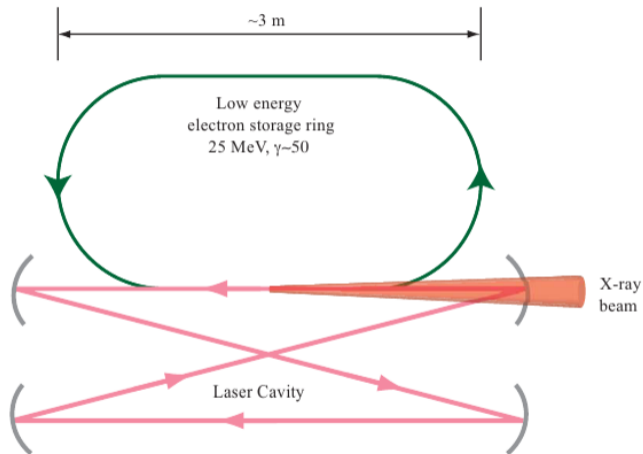
The high brightness usually results in destruction of the sample during the illumination, thus the need for multiple samples and multiple shot experiments

Compact sources



Small low energy, high current
electron ring

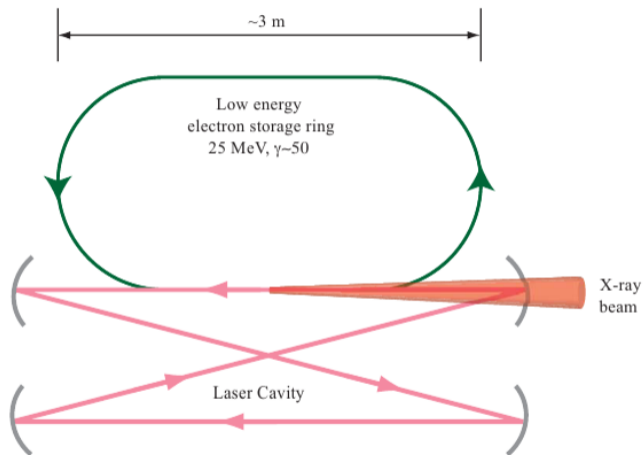
Compact sources



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Straight section intersects a laser cavity

Compact sources

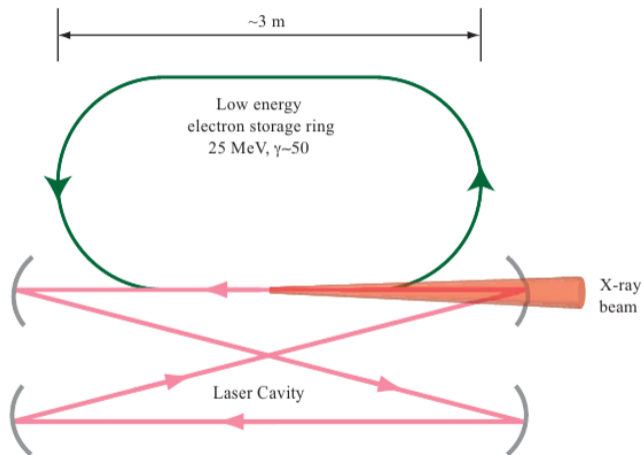


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Straight section intersects a laser cavity

Undulator is the standing wave of the laser, alternatively can consider this an inverse Compton effect

Compact sources



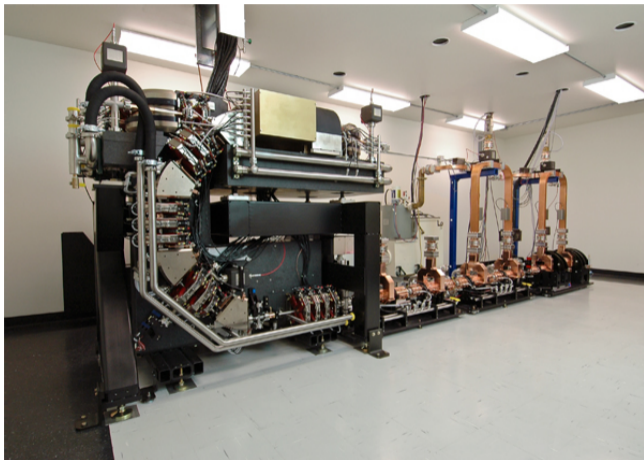
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Low energy x-rays produced are suitable for protein crystallography, SAXS and imaging

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Cost \sim \$5 M plus \sim \$1 M per year service contract

Types of X-ray Detectors



Types of X-ray Detectors



Gas detectors

Types of X-ray Detectors



Gas detectors

- Ionization chamber

Types of X-ray Detectors



Gas detectors

- Ionization chamber
- Proportional counter

Types of X-ray Detectors



Gas detectors

- Ionization chamber
- Proportional counter
- Geiger-Muller tube

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Types of X-ray Detectors



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- Ionization chamber
- Proportional counter
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Scintillation counters

Solid state detectors

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- Silicon drift

Types of X-ray Detectors



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- Ionization chamber
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Charge coupled device detectors

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Charge coupled device detectors

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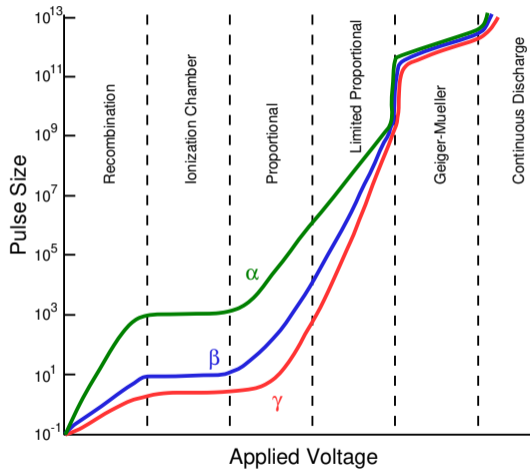
Charge coupled device detectors

- Indirect
- Direct coupled

Gas Detectors



Gas detectors operate in several modes depending on the particle type, gas composition and pressure and voltage applied

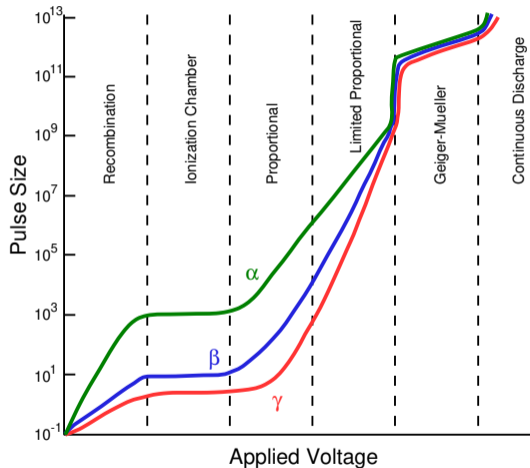


Gas Detectors



Gas detectors operate in several modes depending on the particle type, gas composition and pressure and voltage applied

The most interesting are the ionization, proportional, and Geiger-Mueller



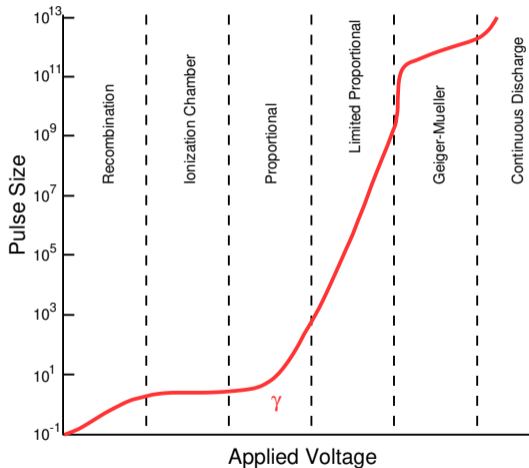
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At a synchrotron, the particle being detected is most often a photon (γ)



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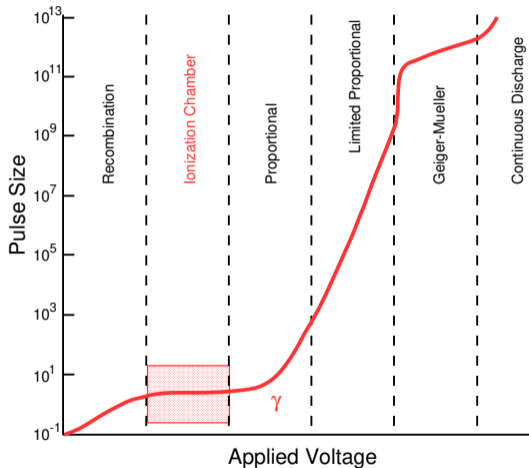


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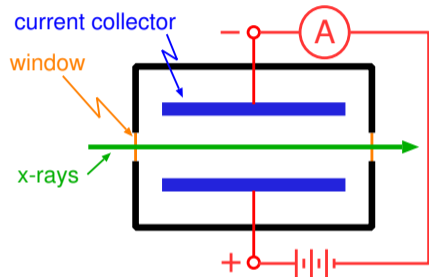
The most useful regime is the ionization region where the output pulse is independent of the applied voltage over a wide range



Ionization Chamber



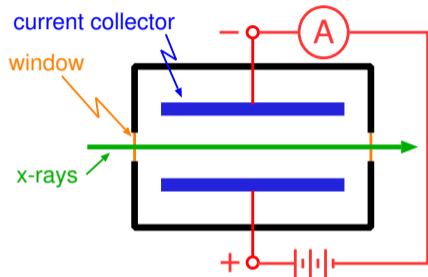
Useful for beam monitoring, flux measurement, fluorescence measurement, spectroscopy.



Ionization Chamber



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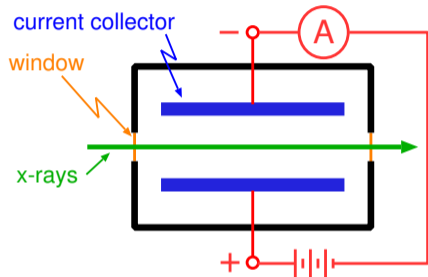
- Closed (or sealed) chamber of length L with gas mixture

$$\mu = \sum \rho_i \mu_i$$

Ionization Chamber



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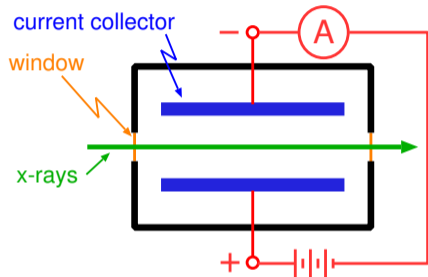


- Closed (or sealed) chamber of length L with gas mixture
$$\mu = \sum \rho_i \mu_i$$
- High voltage applied to plates

Ionization Chamber



Useful for beam monitoring, flux measurement, fluorescence measurement, spectroscopy.



- Calculate fraction of beam absorbed

$$I/I_0 = e^{-\mu L}$$

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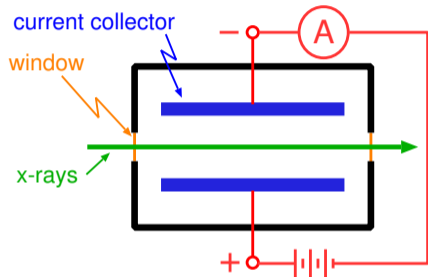
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- When x-ray interacts with gas atom, photoionized electrons swept rapidly to positive electrode and current (nano Amperes) is measured.

- Closed (or sealed) chamber of length L with gas mixture

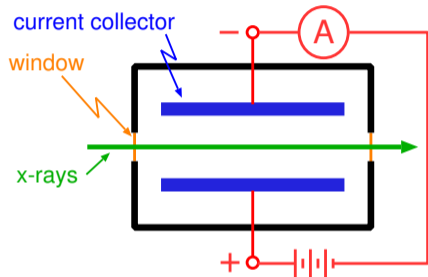
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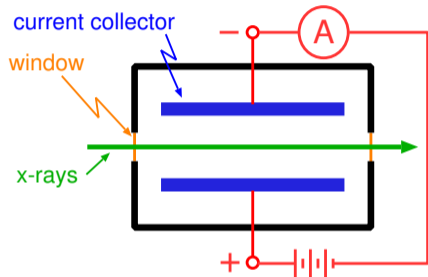
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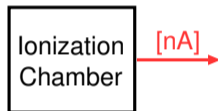
- Closed (or sealed) chamber of length L with gas mixture
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- When x-ray interacts with gas atom, photoionized electrons swept rapidly to positive electrode and current (nano Amperes) is measured.
- Count rates up to 10^{11} photons/s/cm³
- 22-41 eV per electron-ion pair (depending on the gas) makes this useful for quantitative measurements.

Getting a reading



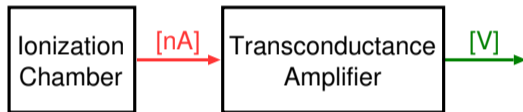
The ionization chamber puts out a **current** in the nA range, this needs to be converted into a useful measurement



Getting a reading



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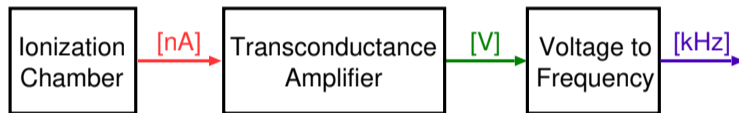


the tiny **current** is fed into an sensitive amplifier with gains of up to 10^{10} which outputs a **voltage** signal of 1-10 V that tracks the input with an adjustable time constant

Getting a reading



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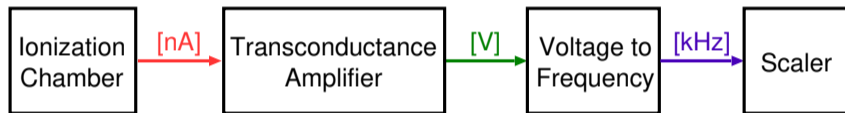
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the **voltage** is converted to a digital signal by a Voltage to Frequency converter which outputs 100 kHz (or more) **pulse frequency** per Volt of input

Getting a reading



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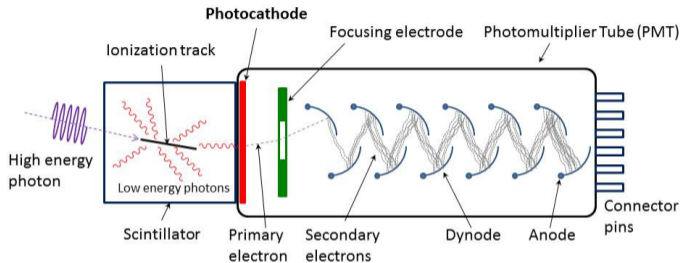
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the digital **pulse train** is counted by a scaler for a user-definable length of time

Scintillation detector



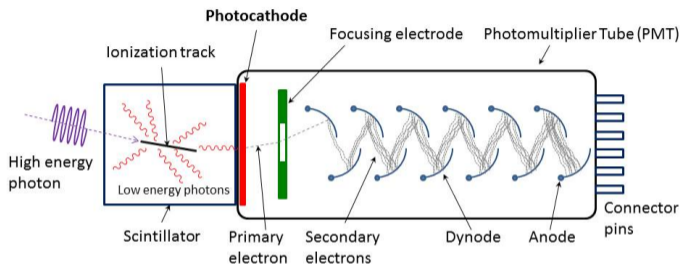
Useful for photon counting experiments with rates less than $10^4/s$



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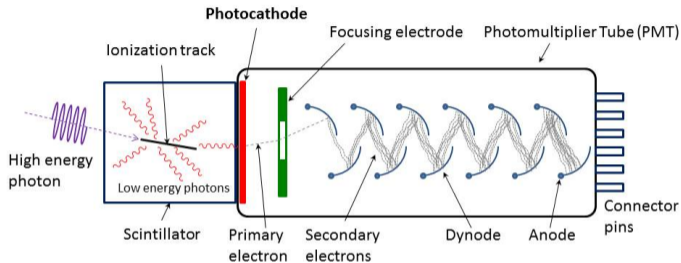


- NaI(Tl), Yttrium Aluminum Perovskite (YAP) or plastic which, absorb x-rays and fluoresce in the visible spectrum.

Scintillation detector



Useful for photon counting experiments with rates less than $10^4/s$

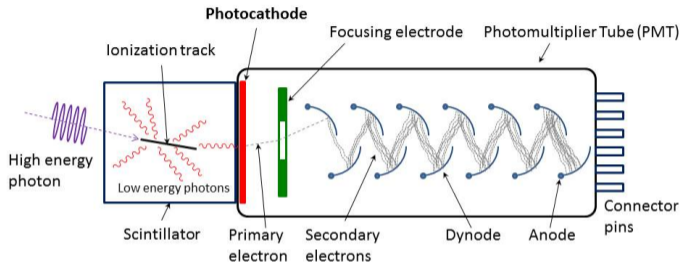


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Scintillation detector



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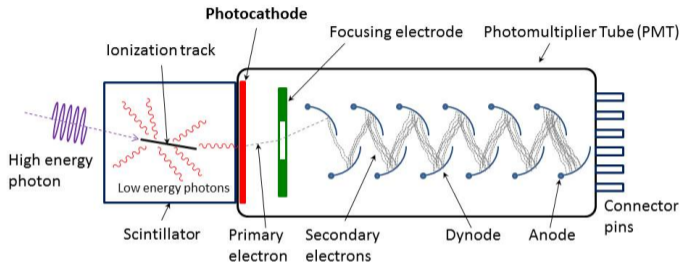


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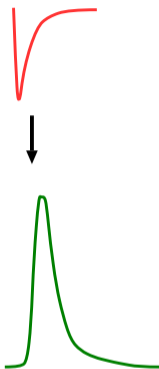
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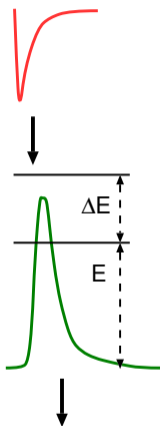
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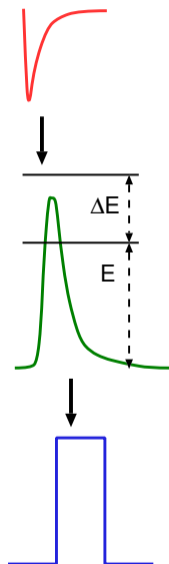


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if the **voltage pulse** falls within the discriminator window, a short **digital pulse** is output from the discriminator and into a scaler for counting

Solid state detectors



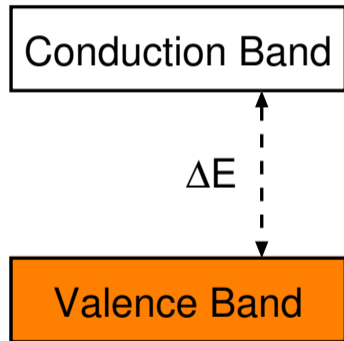
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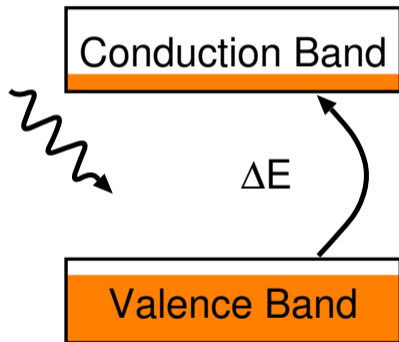
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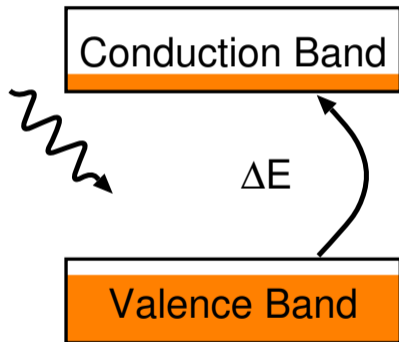
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because of the small energy required to produce an electron-hole pair, one x-ray photon will create many and its energy can be detected with very high resolution

Semiconductor junctions



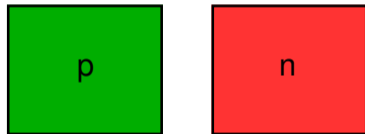
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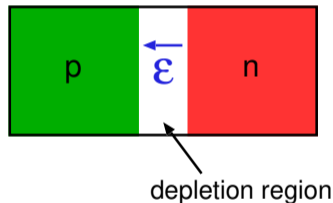
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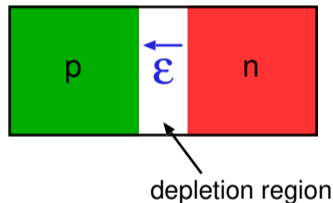


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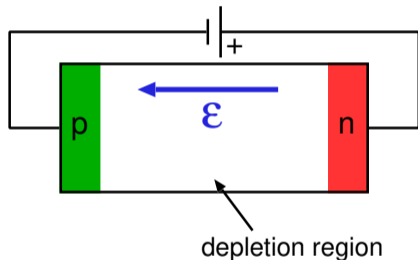
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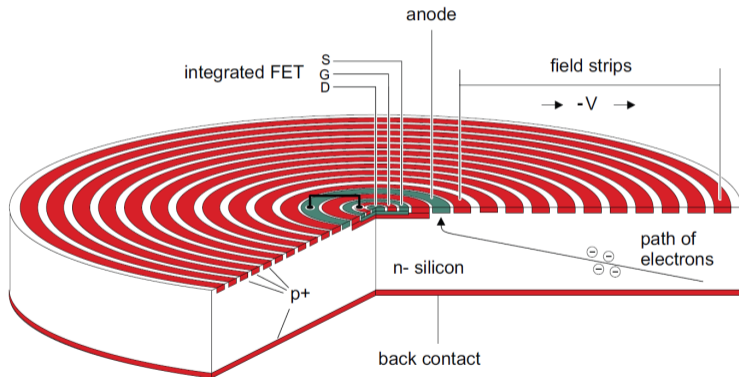
by applying a reverse bias voltage, it is possible to extend the depleted region, make the effective volume of the detector larger and increase the **electric field** to get faster charge collection times



Silicon Drift Detector

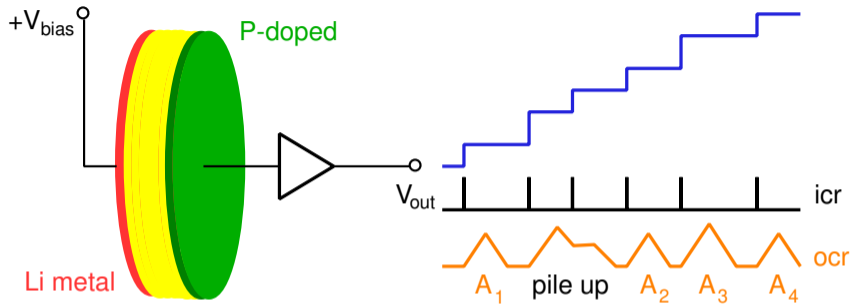


Same principle as intrinsic or p-i-n detector but much more compact and operates at higher temperatures

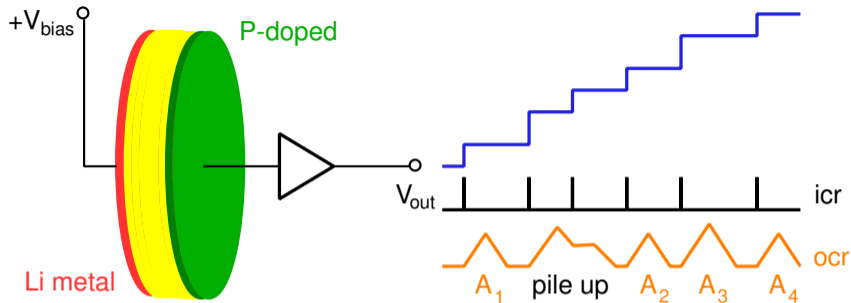


Relatively low stopping power is a drawback

Detector operation

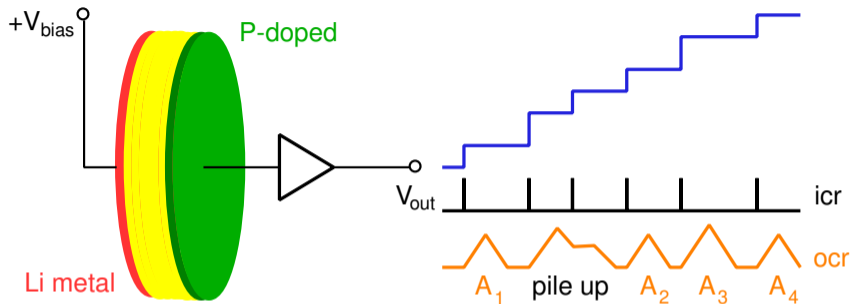


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output current is integrated into **voltage pulses** by a pre-amp, when maximum voltage is reached, output is optically reset

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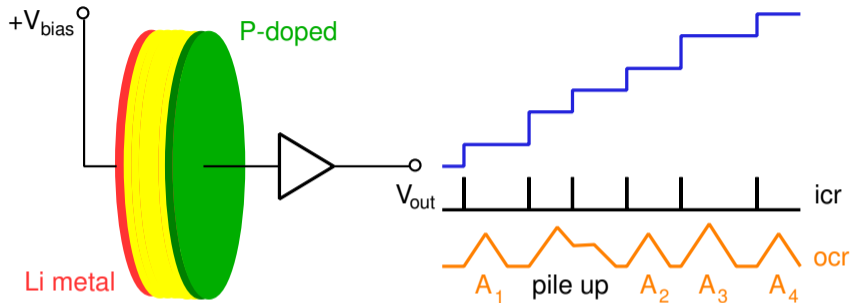


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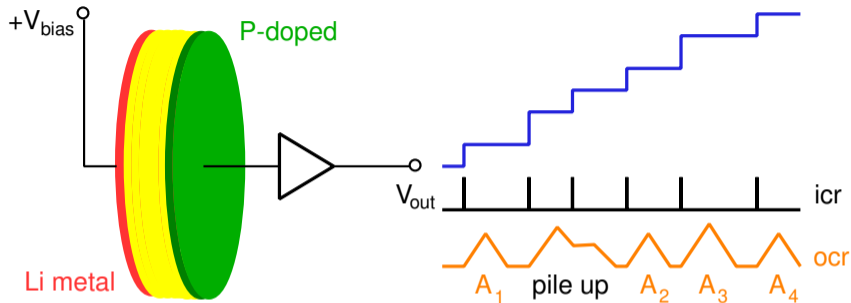
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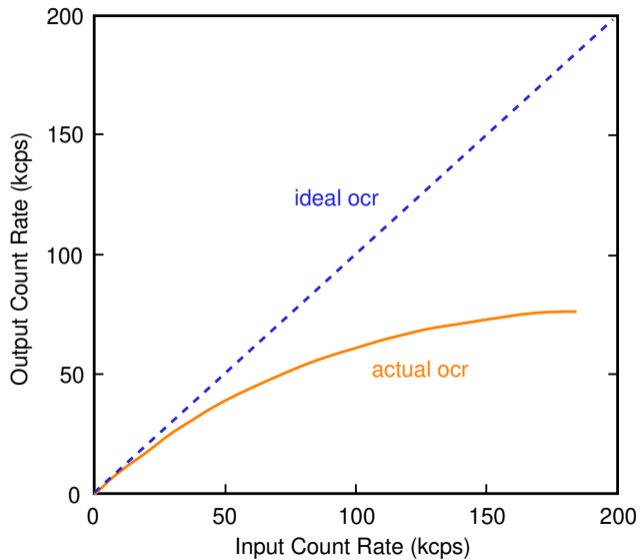


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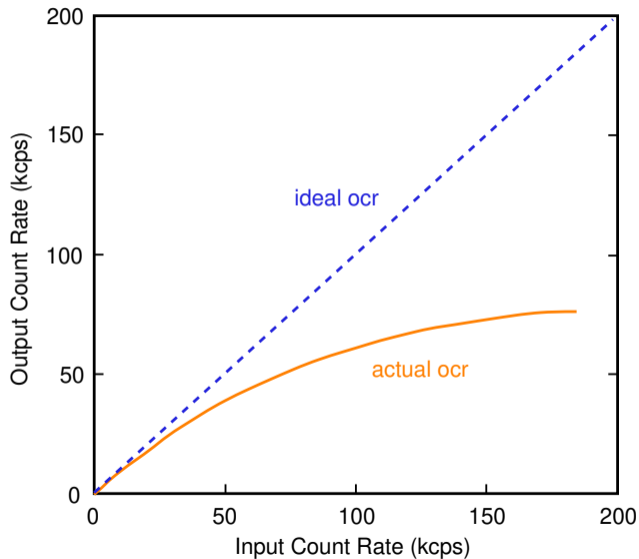
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electronics outputs input count rate (icr), output count rate (ocr), and areas of integrated pulses (A_n)

Dead time correction

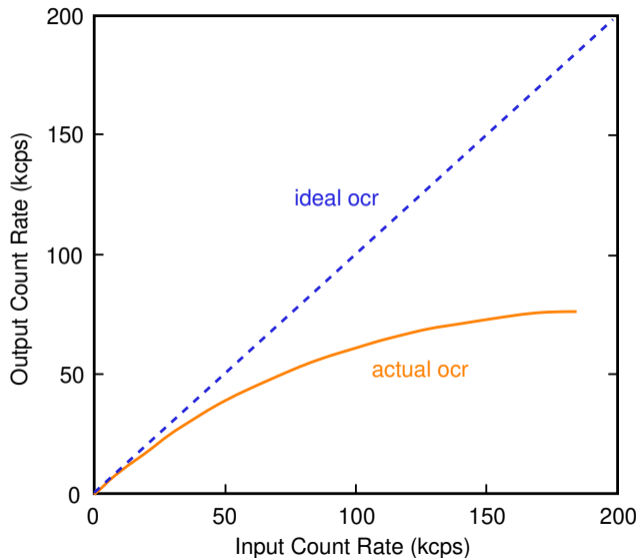


Dead time correction



If the overall input count rate is low enough, the output count rate is linear and can be corrected for dead time by a simple ratio

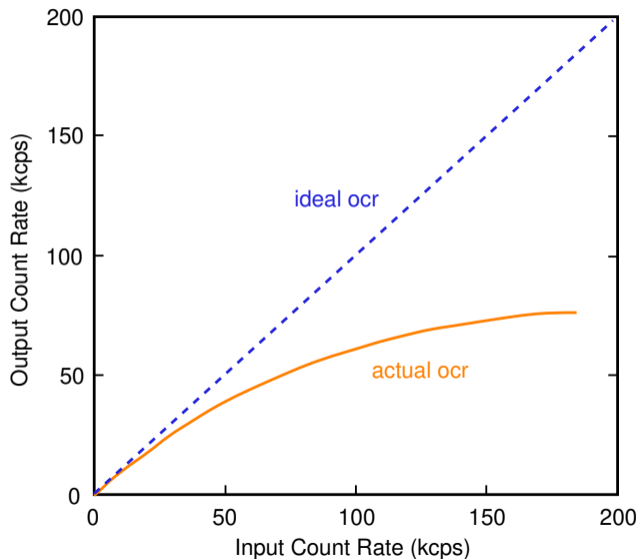
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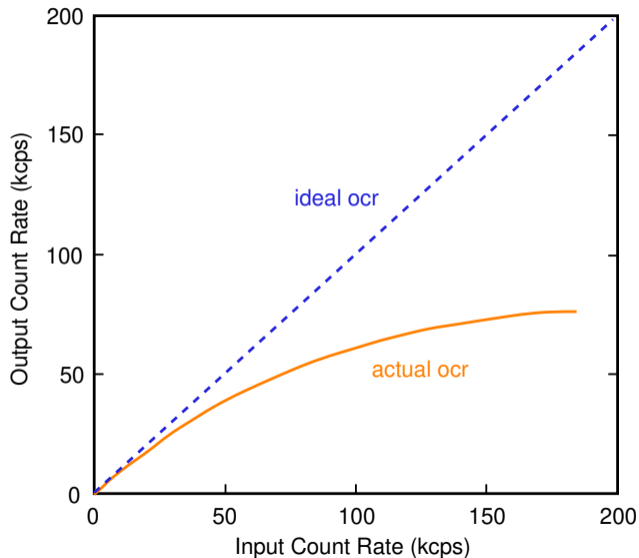


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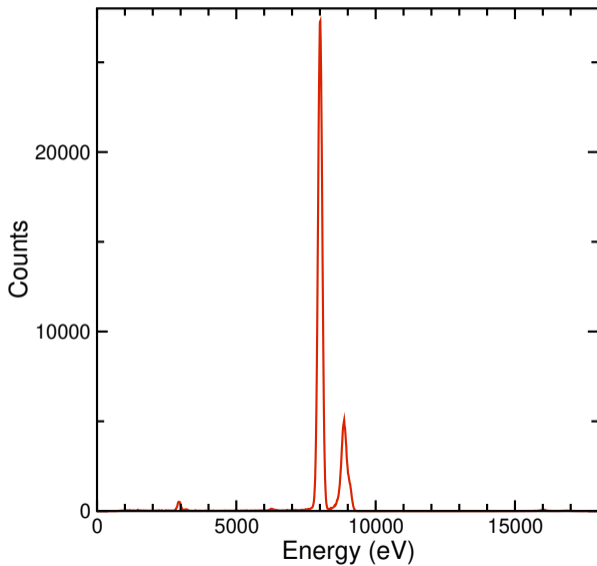
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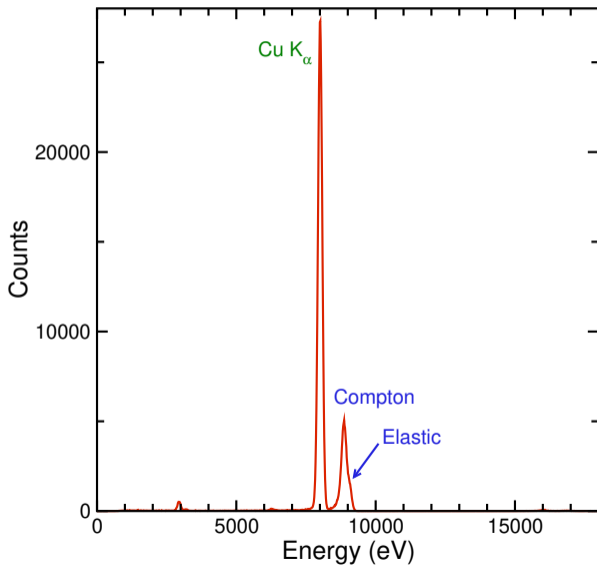
When dead time is too large, correction will not be accurate!

SDD spectrum



Fluorescence spectrum of Cu foil in air
using 9200 eV x-rays

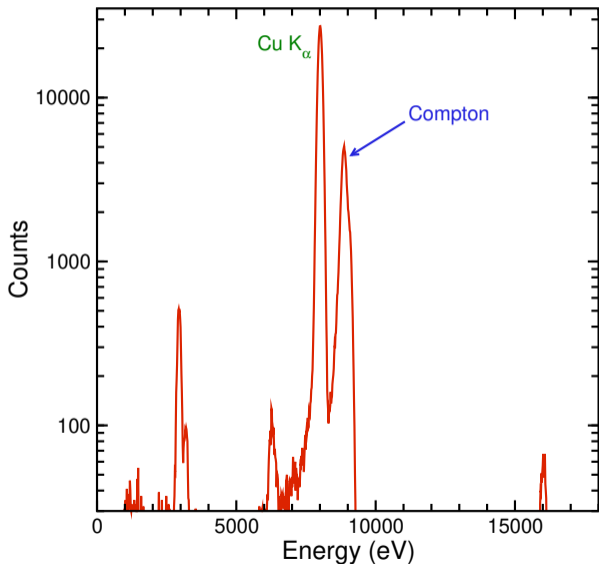
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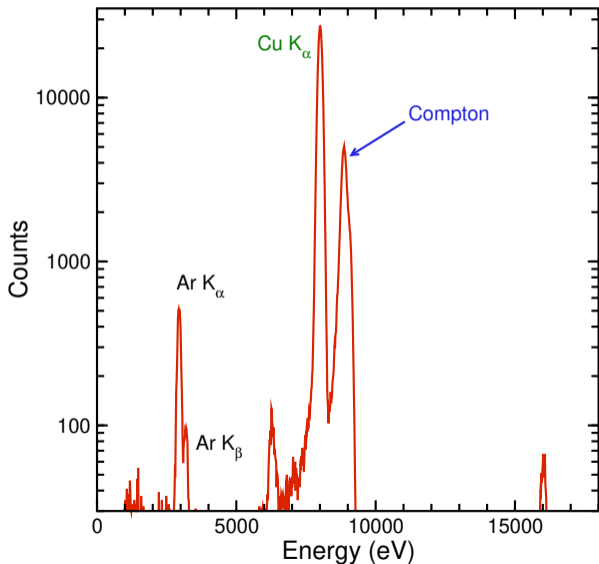
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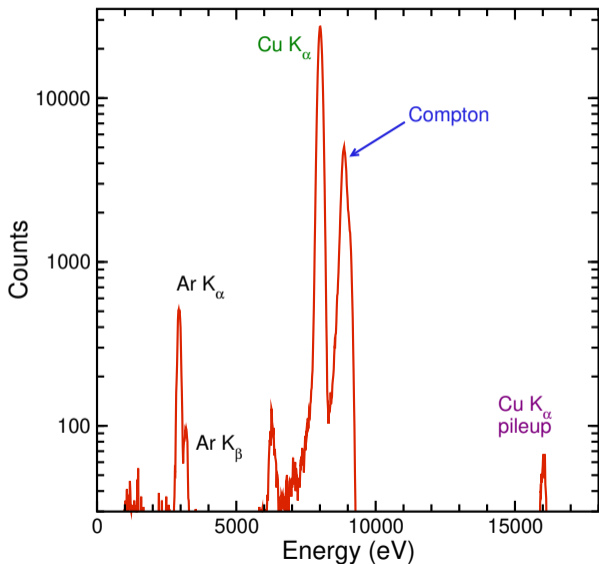


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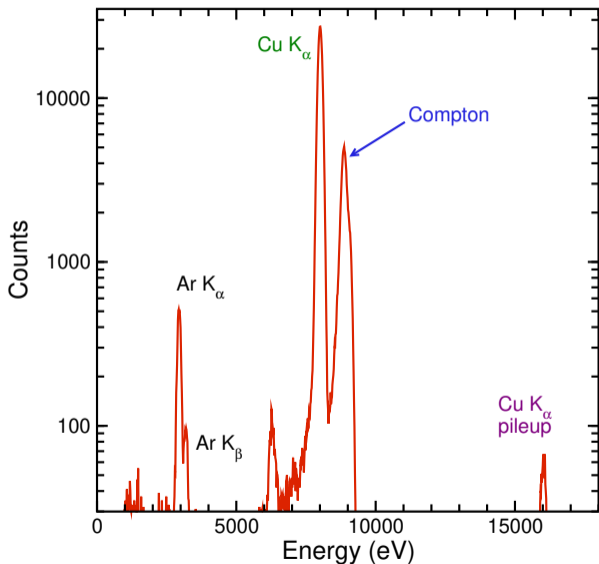
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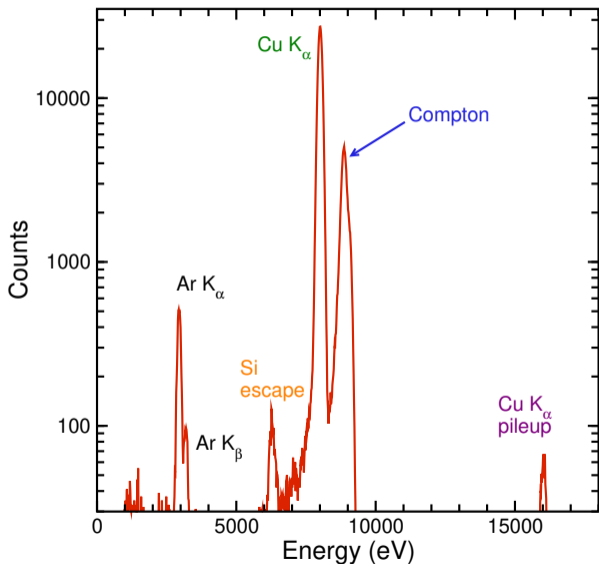
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Si escape peak

$$E_{esc} = 8046 - 1839 = 6207 \text{ eV}$$

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The most advanced detectors can easily cost over a million dollars!

CCD detectors - direct



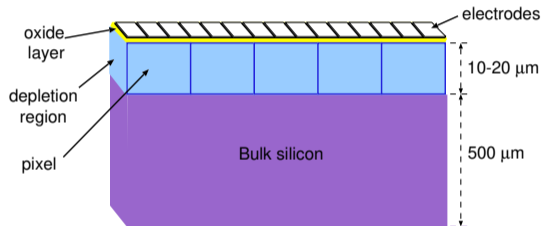
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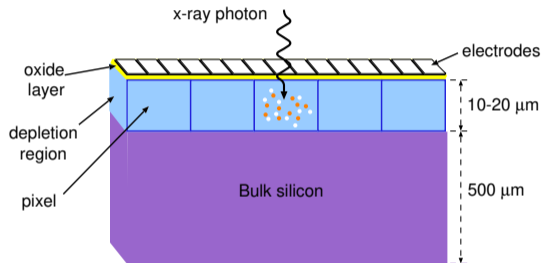
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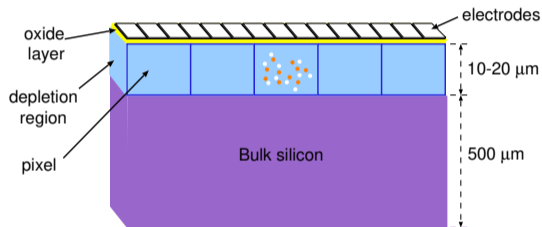
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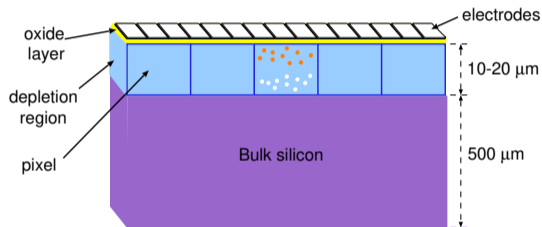
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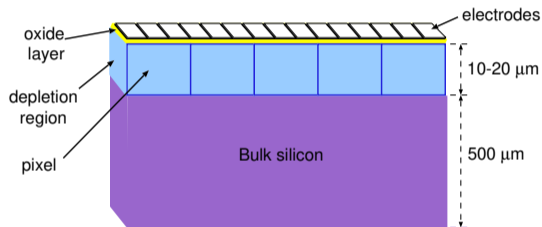
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expensive to make very large, limited sensitivity to high energies

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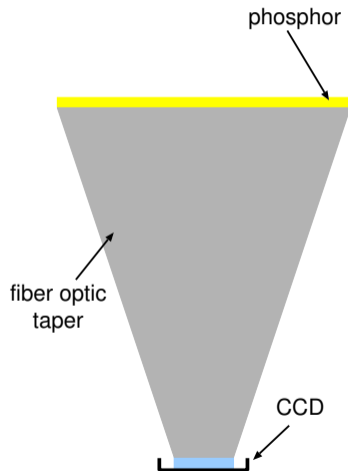
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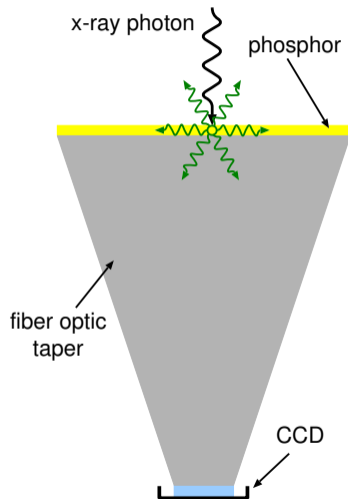
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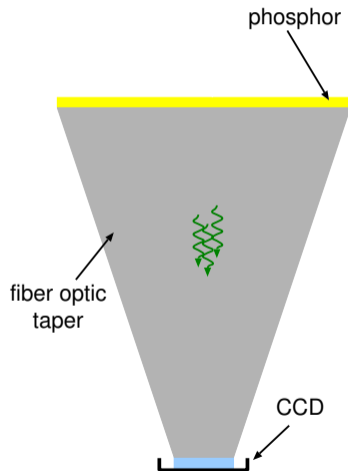


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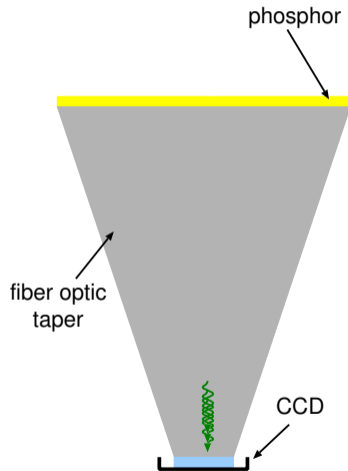
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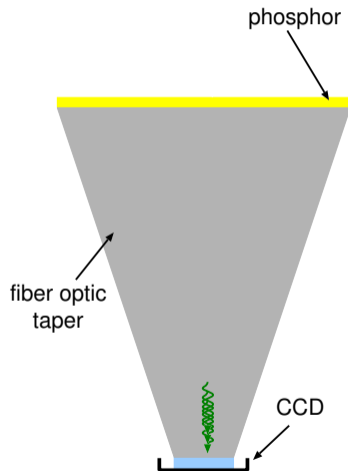
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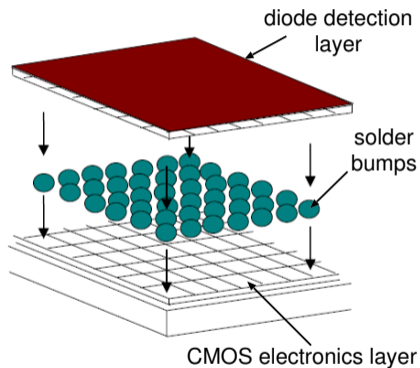
Pixel sizes are usually rather large ($50 \mu\text{m} \times 50 \mu\text{m}$)





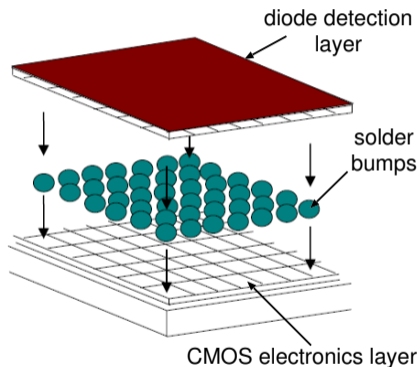
The Pixel Array Detector combines area detection with on-board electronics for fast signal processing

Pixel array detectors - schematic



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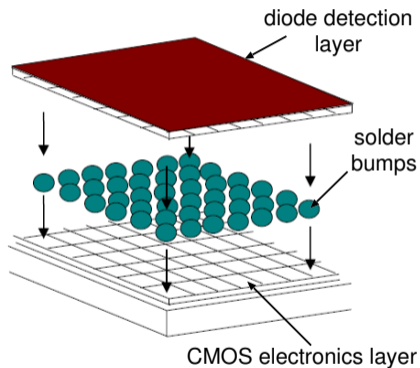
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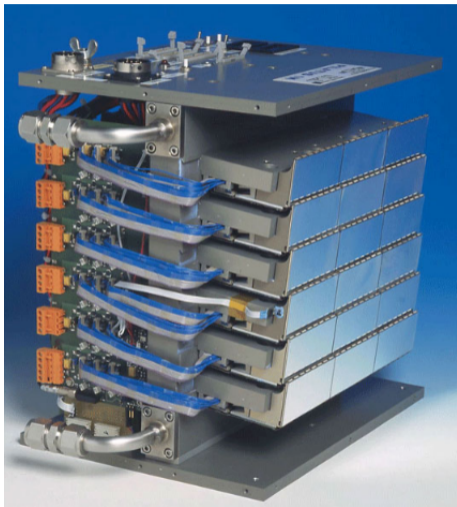


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This permits fast processing and possibly energy discrimination on a per-pixel level

Pixel array detectors - Pilatus



Pixel array detector with 1,000,000 pixels.

Each pixel has energy resolving capabilities & high speed readout.

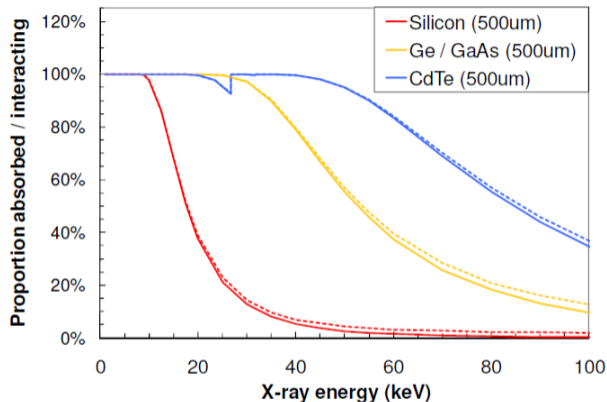
Silicon sensor limits energy range of operation.

from Swiss Light Source



One of the major problems with pixel array detectors and SDDs is the low absorption cross section at high energies

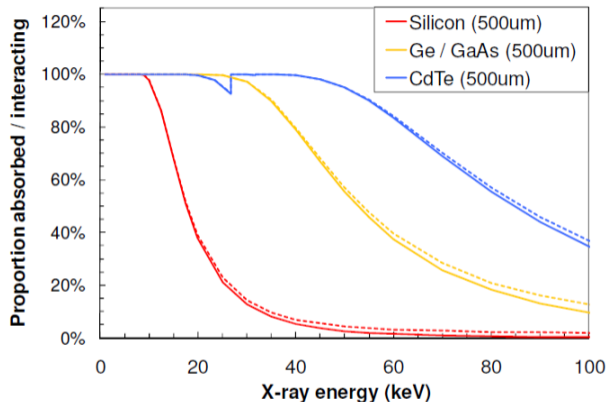
High energy solutions



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The absorption can be significantly enhanced with these higher Z elements while maintaining good energy discrimination capabilities.